

Chip Inductors for RF Applications / Medical Applications (Wire wound-open)

FASTRON's wire wound chip inductors are designed for radio frequency (RF) applications that require optimal Q on high frequency circuits. Its gold flash pad metallization provides better solderability for a higher yield in production. Additionally, their encapsulation not only protects the winding but also allows for surface mount assembly. It comes in compact sizes (from 0302 to 1812) and is available in reel packaging. Unlisted inductance values are usually available upon request. Ferrite core versions are also available for selected case sizes for applications which require higher inductances in a smaller case size.

Applications Used in LC resonant circuits such as oscillator and signal generators, impedance matching, RF filters etc.
 Mobile Telecommunication: GSM, CDMA, TCDMA, cordless phones, 2 way radio
 Automotive Subsystems: TPMS, Keyless Entry, Anti-Theft, GPS
 Wireless Communication: W-LAN, WIFI, WIMAX, RFID, Bluetooth
 Non-magnetic versions for medical imaging applications: ASM series

Technical Data

L – Value (Rated Inductance)	≥ 1 MHz measured with HP 4286A RF LCR meter or equivalent at frequency f_L , 25°C ambient < 1 MHz measured with HP 4285A or equivalent at frequency f_L , 25°C ambient
Q – Factor (min)	≥ 1 MHz measured with E4991B Impedance Analyzer or equivalent at frequency f_Q , 25°C ambient < 1 MHz measured with HP 4285A or equivalent at frequency f_Q , 25°C ambient
SRF (min)	Measured with HP8753ES Network Analyzer or equivalent at 25°C ambient
DCR (max)	Measured at 25°C ambient
Rated DC Current: Irms	Max permissible current that causes a 15°C component temperature rise from 25°C ambient for AS (except 0302AS), AQ, ASM, F & AF Max permissible current that causes a 30°C component temperature rise from 25°C ambient for 0302AS Max permissible current that causes a 40°C component temperature rise from 25°C ambient for AQC, FLP & LDM
Saturation Current: Isat	Max permissible DC bias at 25°C ambient that causes inductivity drop 30% (typ.) related to the unloaded inductivity for FLP & LDM.
Operating Temperature	-40°C to +100°C (Including component self-heating): F & AF -40°C to +125°C (Including component self-heating): FLP & LDM -40°C to +140°C (Including component self-heating): AS (except 0302AS), AQ, ASM & AQC -40°C to +155°C (Including component self-heating): 0302AS
Surface Finishing	Epoxy molded flat top for perfect pick and place assembly
Pad Metallization	Gold flash as top layer for AS, AQ, F, AF & FLP Silver-Palladium-Platinum for ASM & AQC Tin as top layer for LDM
Wire Termination	Spot welding
Recommended Soldering Method	<u>Reflow</u>
Moisture Sensitivity Levels (MSL)	MSL Level 1, indicating unlimited floor life at ≤ 30°C / 85% relative humidity
Solderability	Using lead-free solder (Sn 99.9) at 260°C ± 5°C for 5 ± 0.5 seconds, min 90% solder coverage of metallization Standard: IEC 68-2-20 (Ta)
Resistance to Soldering Heat	Resistant to 260°C ± 5°C for 10 ± 1 seconds Standard: IEC 68-2-20 (Tb)
Resistance to Solvent	Resistant to isopropyl alcohol for 5 ± 0.5 minutes at 23°C ± 5°C Standard: IEC 68-2-45
Climatic Test	Defined by the following standards: IEC 68-2-1 for Cold test: -55°C for 96 hours IEC 68-2-2 for Dry heat test: +85°C for ferrite core and 125°C for ceramic core for 96 hours IEC 60068-2-78 for Humidity test: 40°C at RH 95% for 4 days
Thermal Shock Test	Temperature cycle (ceramic): -40°C to +125°C to -40°C Temperature cycle (ferrite): -40°C to +85°C to -40°C Max/Min temperature duration: 15 minutes Temperature transition duration: 5 minutes Cycles: 25 Standard: MIL-STD-202G
Adhesion of Soldered Component (Shear Test)	Components withstand a pushing force of 10N for 10 ± 1 seconds Standard: IEC 60068-2-21, method Ue ₃
Mechanical Shock	Mil-Std 202 Method 213, Condition C 3 axis, 6 times, total 18 shocks 100 G, 6 ms, half-sine
Vibration	Mil-Std 202 Method 204 20 mins at 5G 10 Hz to 2000 Hz 12 cycles each of 3 orientations

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Ordering Code Example : 0402AS-1N0X-YY → **0402AS-1N0K-01**

0402 AS - 1N0 X - YY
(Case Size) (Core Type) (Inductance Value) (Tolerance) (Packaging Code)

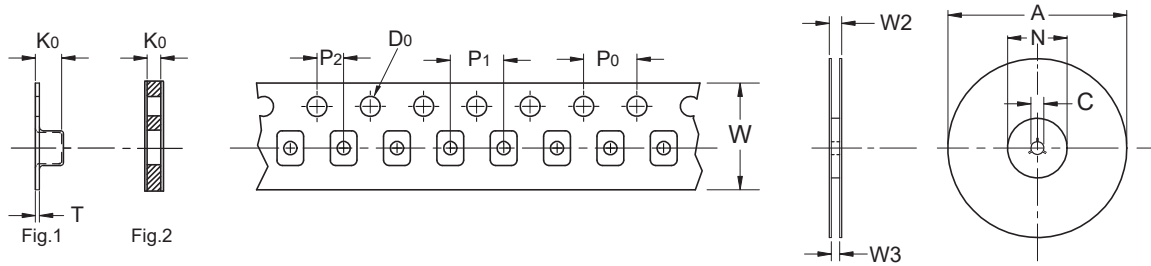
Case Sizes - 0302, 0402, 0603, 0805, 1008, 1206, 1210, 1812

Core Type - AS, AQ, AQC, ASM (Ceramic), F (Ferrite), AF (Ceramic & Ferrite), FLP (Ferrite Low Profile)

Tolerances - F ($\pm 1\%$), G ($\pm 2\%$), A ($\pm 3\%$), J ($\pm 5\%$), K ($\pm 10\%$), L ($\pm 15\%$), M ($\pm 20\%$)

Packaging Code - 01, 04, 08 (Taped / Reel)

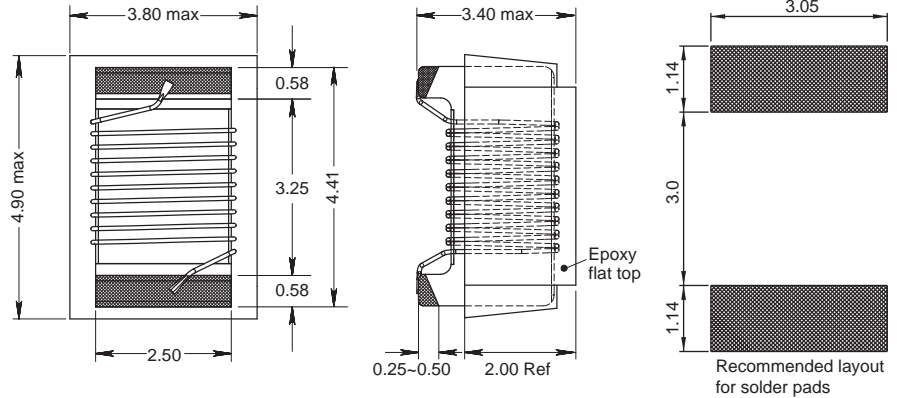
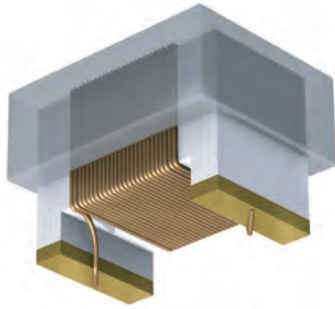
Packaging Specification Schematic



Type	Packaging Code	A	D0	N	C	W2	W3	W	P1	P0	P2	K0	T	Fig
0302	01,08	180	1.55	60	13	11.9	9.5	8	2	4	2	0.50	-	2
0402	01,08	180	1.55	60	13	11.9	9.5	8	2	4	2	0.60	-	2
0603	01,08	180	1.55	60	13	11.4	9.0	8	4	4	2	0.98	-	2
0603	04	330	1.55	100	13	14.4	8.4	8	4	4	2	0.98	-	2
0805	01,08	180	1.55	60	13	11.4	9.0	8	4	4	2	1.63	0.25	1
0805	04	330	1.55	100	13	14.4	8.4	8	4	4	2	1.63	0.25	1
1008	01,08	180	1.50	60	13	11.4	9.5	8	4	4	2	2.23	0.30	1
1008	04	330	1.55	100	13	14.4	8.4	8	4	4	2	1.63	0.25	1
1206	01,08	180	1.50	60	13	18.4	13.7	12	4	4	2	1.80	0.30	1
1206	04	330	1.50	100	13	18.4	12.4	12	4	4	2	1.80	0.30	1
1210	01	180	1.55	60	13	18.4	13.7	12	8	4	2	2.55	0.30	1
1210	04	330	1.55	100	13	18.4	12.4	12	8	4	2	2.55	0.30	1
1812	01	180	1.50	60	13	18.4	13.7	12	8	4	2	3.70	0.35	1
1812	04	330	1.50	100	13	18.4	12.4	12	8	4	2	3.70	0.35	1

1812 AS

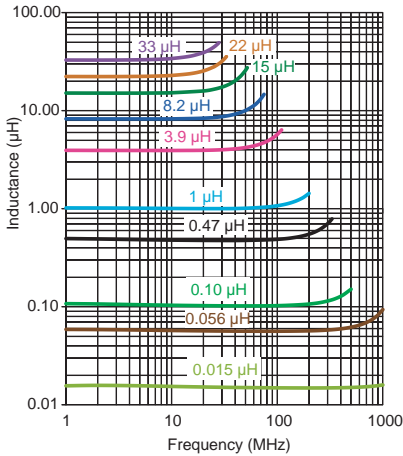
Engineer's Kit: EK-1812AS-X



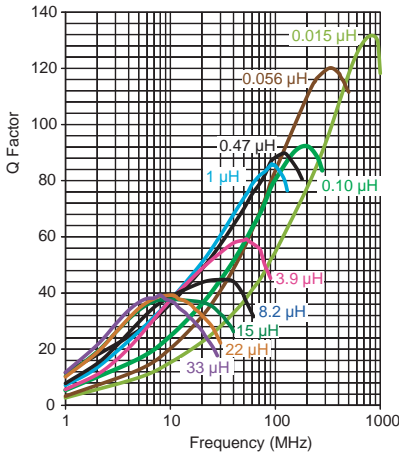
(Wire wound - open)

Chip Inductors for RF Applications

Typical Ls vs Frequency (f)



Typical Q vs Frequency (f)



Single layer (typ)

Part No	Inductance	f _L	Tol	Q	f _a	SRF	DCR	Rated DC
	L (µH)	(MHz)	± (%)	min	(MHz)	(MHz)	max (Ω)	Current max (mA)
1812AS-015K-YY	0.015	50	10	70	500	2400 min	0.035	1550
1812AS-022K-YY	0.022	50	10	70	500	2300 min	0.050	1550
1812AS-033K-YY	0.033	50	10	70	500	1850 min	0.060	1500
1812AS-047K-YY	0.047	50	10	70	250	1100 min	0.060	1500
1812AS-056K-YY	0.056	50	10	70	250	900 min	0.070	1350
1812AS-068K-YY	0.068	50	10	70	250	900 min	0.070	1350
1812AS-082K-YY	0.082	50	10	70	250	900 min	0.080	1300
1812AS-R10K-YY	0.10	50	10	70	250	650 min	0.080	1300
1812AS-R12K-YY	0.12	50	10	70	100	650 min	0.10	1050
1812AS-R15K-YY	0.15	50	10	68	100	600 min	0.13	1000
1812AS-R22K-YY	0.22	50	10	68	100	600 min	0.17	800
1812AS-R27K-YY	0.27	50	10	68	100	500 min	0.19	800
1812AS-R33K-YY	0.33	50	10	64	100	400 min	0.20	700
1812AS-R37K-YY	0.37	50	10	64	100	400 min	0.22	650
1812AS-R47K-YY	0.47	50	10	64	100	400 min	0.30	500
1812AS-1R0K-YY	1.0	7.9	10	62	50	277 min	1.20	480
1812AS-1R2K-YY	1.2	7.9	10	60	50	240 min	1.20	480
1812AS-1R5K-YY	1.5	7.9	10	60	50	220 min	1.60	430
1812AS-1R8K-YY	1.8	7.9	10	60	50	200 min	2.00	380
1812AS-2R2K-YY	2.2	7.9	10	63	50	180 min	2.20	340
1812AS-2R7K-YY	2.7	7.9	10	63	50	160 min	3.20	300
1812AS-3R3K-YY	3.3	7.9	10	50	50	145 typ	3.80	270
1812AS-3R9K-YY	3.9	7.9	10	50	50	130 typ	5.00	240
1812AS-4R7K-YY	4.7	7.9	10	50	50	120 typ	5.40	230
1812AS-5R6K-YY	5.6	7.9	10	40	50	105 typ	5.70	220
1812AS-6R8K-YY	6.8	7.9	10	40	50	103 typ	6.60	210
1812AS-8R2K-YY	8.2	7.9	10	38	50	94 typ	7.00	200
1812AS-100K-YY	10	7.9	10	38	50	80 typ	7.70	190
1812AS-120K-YY	12	2.5	10	38	10	74 typ	8.70	180
1812AS-150K-YY	15	2.5	10	37	10	59 typ	9.60	170
1812AS-180K-YY	18	2.5	10	36	10	59 typ	10.5	160
1812AS-220K-YY	22	2.5	10	36	10	45 typ	13.0	155
1812AS-270K-YY	27	2.5	10	36	10	35 typ	14.0	150
1812AS-330K-YY	33	2.5	10	36	10	35 typ	16.5	145
1812AS-390K-YY	39	2.5	10	32	10	25 typ	23.5	80
1812AS-470K-YY	47	2.5	10	32	10	20 typ	39.0	80
1812AS-560K-YY	56	2.5	10	32	10	20 typ	41.0	60
1812AS-680K-YY	68	2.5	10	32	10	18 typ	54.0	58
1812AS-820K-YY	82	2.5	10	32	10	15 typ	59.0	55

Core Material: Ceramic

Revision date: 11 Jan 2022

SPQ: Taped / Reel 600 [-01]
2200 [-04]

Remarks: - Unlisted inductance values available upon request.
- 2% and 5% tolerance available upon request.